

Search Notes



Application/Control No.

10/790,785

Examiner

Patrick J. Lee

Applicant(s)/Patent under Reexamination

MITAMURA ET AL.

Art Unit

2878

SEARCHED

Class	Subclass	Date	Examiner
250	231.13, 231.14, 231.17, 237R	6/10/05 6/13/05 6/14/05	PL
250	237G		PL
341	13-14		PL
33	1PT		PL
356	614-616		PL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Consulted S. Allen	6/9/2005	PL
East (see attached)	6/10/2005	PL
East (see attached)	6/13/2005	PL
East (see attached)	6/14/2005	PL